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APR 23 2004 PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Complete If Known	
				Application Number	10/602,943
				Filing Date	June 24, 2003
				First Named Inventor	Rodriguez et al.
				Group Art Unit	2823
				Examiner Name	Hsien Ming Lee
Sheet	1	of	1	Attorney Docket No.	TI-35492

U.S. PATENT DOCUMENTS						
Exam. Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Exam. Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
Lee	CA	"Fatigue and Retention Reliability of Low Voltage PZT Ferroelectric Films", J. RODRIGUEZ, S. AGGARWAL, S. MARTIN, S. SUMMERFELT, K.R. UDAYAKUMAR, T. MOISE, R. BAILEY, F. CHU, S. SUN, G. FOX and T. DAVENPORT, Abstract/Conference presentation, March, 2003, 2 pgs.	
Lee	CB	"Polarization as a Driving Force in Accelerated Retention Measurements on Ferroelectric Thin Films", S. D. TRAYNOR, IEEE, 1998, Pgs. 15-18.	
	CC		
	CD		
	CE		
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Examiner Signature	<i>Hsien Ming Lee</i>	Date Considered	7/27/2004
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